## **CLAIMS:**

- 1. A rotatable platen assembly, comprising a patterned surface for securing a pad thereto, the patterned surface comprising:
- (a) one or more raised portions disposed on the patterned surface defining a mounting surface; and
  - (b) a recessed area defined by the one or more raised portions.
- 2. The rotatable platen assembly of claim 1, wherein the recessed area comprises a plurality of grooves.
- 3. The rotatable platen assembly of claim 1, wherein at least a portion of the recessed area extends to a perimeter of the rotatable platen.
- 4. The rotatable platen assembly of claim 1, wherein the rotatable platen is part of a chemical mechanical polishing system.
- 5. The rotatable platen assembly of claim 1, wherein the platen comprises aluminum.
- 6. The rotatable platen assembly of claim 1, wherein the pad comprises polyurethane.
- 7. The rotatable platen assembly of claim 1, wherein the pad comprises a plastic foam.
- 8. An apparatus for polishing a substrate, comprising:
  - (a) a rotatable platen, comprising a patterned surface for securing a pad thereto, the patterned surface comprising:
- (i) one or more raised portions defining a mounting surface; and

## PATENT 3522C2/PDD/CMP/RKK

- (ii) a recessed area defined by the one or more raised portions; and
  - (b) a pad disposed on the mounting surface.
- 9. The apparatus of claim 8, further comprising a coating disposed on the patterned surface.
- 10. The apparatus of claim 8, wherein the pad comprises polyurethane.
- 11. The apparatus of claim 8, wherein the pad comprises a plastic foam.
- 12. The apparatus of claim 8, wherein the recessed area comprises a plurality of grooves.
- 13. The apparatus of claim 8, wherein at least a portion of the recessed area extends to a perimeter of the rotatable platen.
- 14. The apparatus of claim 8, wherein the recessed area and the pad define a plurality of pathways.
- 15. The apparatus of claim 14, wherein at least a portion of the plurality of pathways extend to a perimeter of the rotatable platen to allow fluid communication between a backside of the pad and an environment of the rotatable platen.
- 16. A substrate polishing apparatus, comprising:
- (a) one or more polishing stations each including a rotatable platen wherein at least one of the rotatable platen comprises a patterned surface for securing a pad thereto, the patterned surface comprising:
- (i) one or more raised portions defining a mounting surface;

## PATENT 3522C2/PDD/CMP/RKK

- (ii) a recessed area defined by the one or more raised portions; and
- (b) one or more polishing heads rotatably mounted above the rotatable platens.
- 17. The apparatus of claim 16, further comprising a pad disposed on the mounting surface.
- 18. The apparatus of claim 16, further comprising a coating disposed on the patterned surface.
- 19. The apparatus of claim 16, further comprising a motor coupled to the rotatable platen to selectively impart rotation.
- 20. The apparatus of claim 16, wherein the recessed area comprises a plurality of grooves.